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**Universal Mobile Telecommunications System (UMTS);  
User Equipment (UE) conformance specification;  
Radio transmission and reception (FDD);  
Part 1: Conformance specification  
(3GPP TS 34.121-1 version 13.0.0 Release 13)**



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## Foreword

This Technical Specification has been produced by the 3<sup>rd</sup> Generation Partnership Project (3GPP).

The contents of the present document are subject to continuing work within the TSG and may change following formal TSG approval. Should the TSG modify the contents of the present document, it will be re-released by the TSG with an identifying change of release date and an increase in version number as follows:

Version x.y.z

where:

- x the first digit:
  - 1 presented to TSG for information;
  - 2 presented to TSG for approval;
  - 3 or greater indicates TSG approved document under change control.
- y the second digit is incremented for all changes of substance, i.e. technical enhancements, corrections, updates, etc.
- z the third digit is incremented when editorial only changes have been incorporated in the document.

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## Introduction

The present document is part 1 of a multi-parts TS:

**3GPP TS 34.121-1: User Equipment (UE) conformance specification; Radio transmission and reception (FDD); Part 1: Conformance specification.**

3GPP TS 34.121-2 [32]: User Equipment (UE) conformance specification; Radio transmission and reception (FDD); Part 2: Implementation Conformance Statement (ICS).

NOTE: TS 34.121 has been converted to multipart TS with version 7.0.0. Previous versions are a single part standard 34.121.

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# 1 Scope

The present document specifies the UTRA measurement procedures for the conformance test of the user equipment (UE) that contain transmitting characteristics, receiving characteristics and performance requirements in addition to requirements for support of RRM (Radio Resource Management) in FDD mode. In addition it specifies conformance testing of RRM requirements for support of E-UTRA when the UE operates in UTRA mode.

NOTE: Conformance testing of RRM requirements for support of UTRA when the UE operates in E-UTRA mode are specified in TS 36.521-3 [38].

The requirements are listed in different clauses only if the corresponding parameters deviate. More generally, tests are only applicable to those mobiles that are intended to support the appropriate functionality. To indicate the circumstances in which tests apply, this is noted in the "*definition and applicability*" part of the test.

For example only Release 5 and later UE declared to support HSDPA shall be tested for this functionality. In the event that for some tests different conditions apply for different releases, this is indicated within the text of the test itself.

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# 2 References

The following documents contain provisions which, through reference in this text, constitute provisions of the present document.

- References are either specific (identified by date of publication, edition number, version number, etc.) or non-specific.
- For a specific reference, subsequent revisions do not apply.
- For a non-specific reference, the latest version applies. In the case of a reference to a 3GPP document (including a GSM document), a non-specific reference implicitly refers to the latest version of that document in the same Release as the present document unless the context in which the reference is made suggests a different Release is relevant (information on the applicable release in a particular context can be found in e.g. test case title, description or applicability, message description or content).
  - For a Release 1999 UE, references to 3GPP documents are to version 3.x.y.
  - For a Release 4 UE, references to 3GPP documents are to version 4.x.y.
  - For a Release 5 UE, references to 3GPP documents are to version 5.x.y.
  - For a Release 6 UE, references to 3GPP documents are to version 6.x.y.
  - For a Release 7 UE, references to 3GPP documents are to version 7.x.y.
  - For a Release 8 UE, references to 3GPP documents are to version 8.x.y.
  - For a Release 9 UE, references to 3GPP documents are to version 9.x.y.

- [1] 3GPP TS 25.101: "UE Radio transmission and reception (FDD)".
- [2] 3GPP TS 25.133: "Requirements for Support of Radio Resource Management (FDD)".
- [3] 3GPP TS 34.108: "Common Test Environments for User Equipment (UE) Conformance Testing".
- [4] 3GPP TS 34.109: "Terminal logical test interface; Special conformance testing functions".
- [5] 3GPP TS 25.214: "Physical layer procedures (FDD)".
- [6] 3GPP TR 21.905: "Vocabulary for 3GPP Specifications".
- [7] 3GPP TR 25.990: "Vocabulary".
- [8] 3GPP TS 25.331: "Radio Resource Control (RRC); Protocol Specification".
- [9] 3GPP TS 25.433: "UTRAN Iub Interface NBAP Signalling".